

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10575289	VAN LIER ET AL.
	Examiner	Art Unit
	SHEELA C CHAWAN	2624

SEARCHED

Class	Subclass	Date	Examiner
382	197, 199, 279, 132, 128, 241, 266, 242, 131, 205,243,132, 173, 260	1/18/09	SCC
375	E7.081, E7.111,E7.211,	"	"
358	1.9, 462, 3.27, 1.2,	"	"
348	416.1	"	"
345	471	"	"

SEARCH NOTES

Search Notes	Date	Examiner
SEARCH EAST AND OTHER DATA BASE , SEE THE SEARCH HISTORY.	1/18/09	SCC
SEARCH INVENTOR NAME SEARCH.	"	"

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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